

- ☐ Bowyer, K. (1)

-

- ☐ Wilpon, J.G. (1)

-

- ☐ Rahner, L.R. (1)

-

- ☐ Mann, S. (1)

-

- ☐ Kamm, C.A. (1)

Affiliation

-

- ☐ AT&T Labs. Res., Florham Park, NJ (1)

Publication Title

-

- ☐ Proceedings of the IEEE (1)

Subject

-

- ☐ Computing & Processing (Hardware/Software) (2)

-

- ☐ General Topics for Engineers (Math, Science & Engineering) (2)

-

- ☐ Fields, Waves & Electromagnetics (1)

-

- ☐ Communication, Networking & Broadcasting (1)

-

- ☐ Engineered Materials, Dielectrics & Plasmas (1)

-

- ☐ Components, Circuits, Devices & Systems (1)

-

- ☐ Engineering Profession (1)

Brought to you by

US Dept of Commerce

- Your institute subscribes to:
- [IEEE/IEET Electronic Library \(IEL\)](#), [IEEE Draft Standards Online Subscription](#)
- [What can I access?](#)

[Terms of Use](#)

SEARCHES FOR THIS SESSION

- [\(\(email AND count\) AND challenge\), visual carbonad \(3\)](#)
- [\(\(email AND count\) AND challenge\) \(8744\)](#)
- [More Search History](#)

